Search	Notes
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/735,112	ALLEN ET AL.	
Examiner	Art Unit	
Paul D. Kim	3729	

	SEAR	CHED	
Class	Subclass	Date	Examiner
29	603.07 603.13 603.14- 603.16	11/15/2006	PK
	603.18		
	603.25 606		
216	62,65 66		
360	122 126 317		
427	127 128		
451	5,41	V	
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TMI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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	RCH NOTES SEARCH STRATEGY	<b>(</b> )
	DATE	EXMR
Text Search EAST/PGPub	11/15/2006	PK
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